

STD9NM50N - STD9NM50N-1 STF9NM50N - STP9NM50N

N-channel 500V - 0.47Ω - 7.5A - TO-220 - TO-220FP - IPAK - DPAK Second generation MDmesh™ Power MOSFET

Features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	Ι _D
STD9NM50N	550V	<0.56Ω	7.5A
STD9NM50N-1	550V	<0.56Ω	7.5A
STP9NM50N	550V	<0.56Ω	7.5A
STF9NM50N	550V	<0.56Ω	7.5A ⁽¹⁾

1. Limited only by maximum temperature allowed

- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

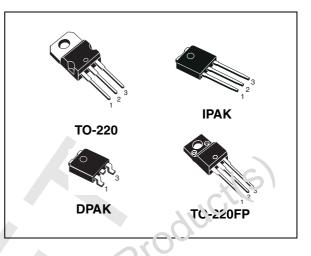
Description

This series of devices implements second generation MDmesh[™] technology. This revolutionary Power MOSFET associates a new vertical structure to the Company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the nost demanding high efficiency converters.

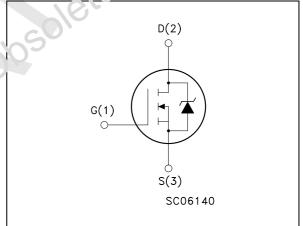
Applications

Switching application

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Internal schematic diagram



Part number	Marking	Package	Packaging
STD9NM50N-1	D9NM50N	IPAK	Tube
STD9NM50N	D9NM50N	DPAK	Tape & reel
STP9NM50N	P9NM50N	TO-220	Tube
STF9NM50N	F9NM50N	TO-220FP	Tube

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Electrical ratings 1

Table 1.	Absolute n	naximum ratings	
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		Value			
Symbol	Parameter	TO-220 DPAK/IPAK	TO-220FP	Unit	
V _{DS}	Drain-source voltage (V _{GS} =0)	50	00	V	
V _{GS}	Gate-source voltage	±	25	V	
Ι _D	Drain current (continuous) at $T_C = 25^{\circ}C$	7.5	7.5 ⁽¹⁾	А	
Ι _D	Drain current (continuous) at T _C = 100°C	5	5 ⁽¹⁾	А	
I _{DM} ⁽²⁾	Drain current (pulsed)	30	30 ⁽¹⁾	Α	
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	70	25	C W	
dv/dt (3)	Peak diode recovery voltage slope	1	5	V/ns	
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink $(t=1s;T_C=25^{\circ}C)$	-01	2500	v	
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to	o 150	°C	
1. Limited on	ly by maximum temperature allowed				

2. Pulse width limited by safe operating area

3. $I_{SD} \leq 7.5A$, di/dt $\leq 400A/\mu s$, $V_{DD} = 80\% V_{(BR)DSS}$

Thermal data Table 2.

	Symbol	Parameter	TO-220 DPAK/IPAK	TO-220FP	Unit
	Rthj-case	Thermal resistance junction-case max	1.78	5	°C/W
	Rthj-amb	Thermal resistance junction-amb max	62	2.5	°C/W
10	T ₁	Maximum lead temperature for soldering purpose	300		°C
obsoli	Table 3.	Avalanche characteristics			
00	Symbol	Parameter	Мах	value	Unit
			1		

Symbol	Parameter	Max value	Unit
I _{AS}	Avalanche current, repetitive or not- repetitive (pulse width limited by Tj max)	3	A
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, I _D =I _{AS} , V _{DD} = 50V)	150	mJ



Electrical characteristics 2

(T_{CASE}=25°C unless otherwise specified)

Parameter	Test conditions	Min	Тур	Max	Unit
Drain-source breakdown voltage	I _D = 1mA, V _{GS} = 0	500			V
Drain-source voltage slope	Vdd= 400V, Id=7.5A, Vgs=10V		35		V/ns
Zero gate voltage drain current ($V_{GS} = 0$)	V _{DS} = Max rating, V _{DS} = Max rating,Tc = 125°C			1 100	μΑ μΑ
Gate body leakage current $(V_{DS} = 0)$	$V_{GS} = \pm 20V$			100	nA
Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	V
Static drain-source on resistance	V _{GS} = 10V, I _D = 3.7A		0.47	0.56	Ω
	Drain-source breakdown voltageDrain-source voltage slopeZero gate voltage drain current ($V_{GS} = 0$)Gate body leakage current ($V_{DS} = 0$)Gate threshold voltageStatic drain-source on	Drain-source breakdown voltage $I_D = 1mA, V_{GS} = 0$ Drain-source voltage slopeVdd= 400V, Id=7.5A, Vgs=10VZero gate voltage drain current (V_{GS} = 0) $V_{DS} = Max$ rating, $V_{DS} = Max$ rating, Tc = 125°CGate body leakage current (V_{DS} = 0) $V_{GS} = \pm 20V$ Gate threshold voltage $V_{DS} = V_{GS}, I_D = 250\mu A$ Static drain-source on $V_{CS} = 10V, I_D = 3.7A$	Drain-source breakdown voltage $I_D = 1mA, V_{GS} = 0$ 500Drain-source voltage slope $Vdd = 400V, Id = 7.5A, Vgs = 10V$ 500Zero gate voltage drain current ($V_{GS} = 0$) $V_{DS} = Max rating, V_{DS} = Max rating, Tc = 125^{\circ}C$ 500Gate body leakage current ($V_{DS} = 0$) $V_{GS} = \pm 20V$ 2Gate threshold voltage $V_{DS} = V_{GS}, I_D = 250\muA$ 2Static drain-source on $V_{QS} = 10V, I_D = 3.7A$ 2	Drain-source breakdown voltageID1mA, VGS = 0500Drain-source voltage slopeVdd= 400V, Id=7.5A, Vgs=10V500Zero gate voltage drain current (VGS = 0)VDS = Max rating, VDS = Max rating, Tc = 125°C35Gate body leakage current (VDS = 0)VGS = ±20V1Gate threshold voltageVDS = VGS, ID = 250µA23Static drain-source onVOS = 10V, ID = 3.7A0.47	Drain-source breakdown voltageID1mA, VGS = 05001mBDrain-source voltage slopeVdd= 400V, Id=7.5A, Vgs=10V3535Zero gate voltage drain current (VGS = 0)VDS = Max rating, VDS = Max rating, Tc = 125°C1 100Gate body leakage current (VDS = 0)VGS = ±20V100Gate threshold voltageVDS = VGS, ID = 250µA23Static drain-source onVGS = 10V, ID = 3.7A0.470.56

Table 4. **On/off states**

	1. Charact	eristics value at turn off on induct Dynamic	ive load				
	Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
	g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} =15V, I _D = 3.7A		5		S
	C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 50V, f=1MHz, V _{GS} =0		570 46 6		pF pF pF
	C _{oss eq.} ⁽²⁾	Equivalent output characteristics	V_{GS} =0, V_{DS} = 0V to 400V		94		pF
	Rg	Gate input resistance	f=1MHz Gate DC Bias=0 Test signal level=20mV Open drain		6		Ω
Obsole	Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 400V, I_D = 7.5A V_{GS} =10V (see Figure 16)		20 4 10		nC nC nC

Table 5. Dynamic

 $C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} 2.



	ownoning times					
Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} =250V, I _D =3.7A, R _G =4.7 Ω , V _{GS} =10V (see Figure 15)		11 16 45 19		ns ns ns ns

Table 6. Switching times

Table 7. Source drain diode

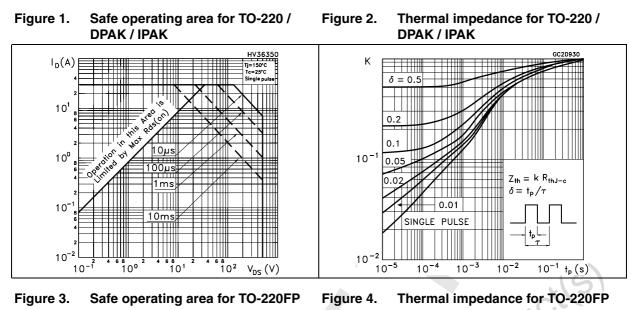
Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				7.5 30	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =7.5A, V _{GS} =0			1.2	v
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =7.5A, di/dt=100A/μs, V _{DD} =100V, Tj=150°C <i>(see Figure 17)</i>		420 3 14		ns μC Α
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =7.5A, di/dt=100A/µs, V _{DD} =100V, Tj= 25°C (<i>see Figure 17</i>)	070	280 2 14		ns μC Α

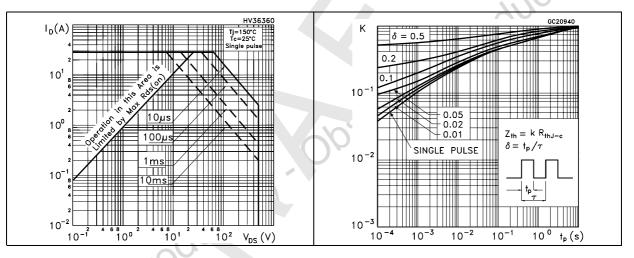
1. Pulse width limited by safe operating area

2. Pulsed: pulse duration = 300µs, duty cycle 1.5%



2.1 Electrical characteristics (curves)





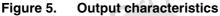
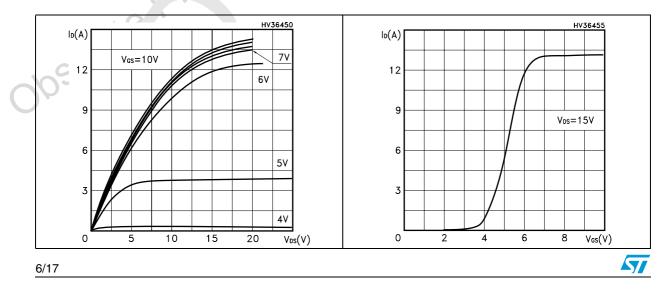


Figure 6. Transfer characteristics



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Figure 7. Transconductance

Figure 8. Static drain-source on resistance

 $V_{GS} = 10V$

R DS(on)

(mΩ)

0.60

0.55

0.50

0.45

0.40L

2

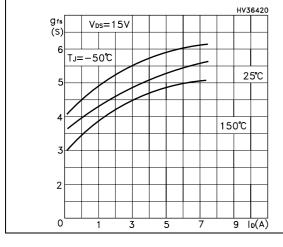
Figure 10. Capacitance variations

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 $I_{D}(A)$





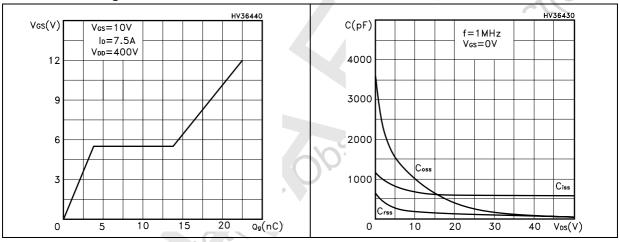
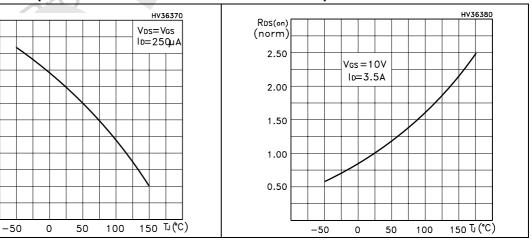


Figure 11. Normalized gate threshold voltage Figure 12. Normalized on resistance vs. vs. temperature

temperature



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Vgs (th) (norm)

1.1

1.0

0.9

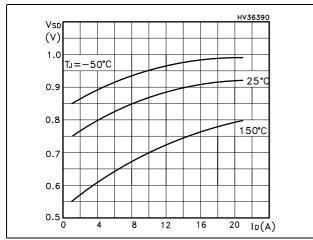
0.8

0.7

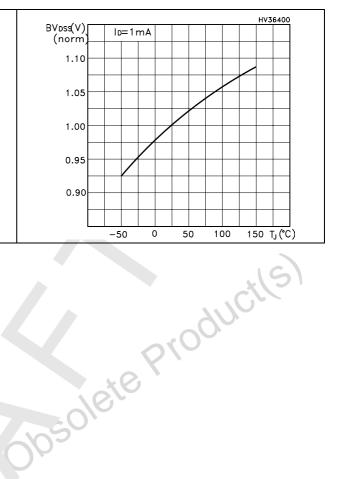
0.6

Figure 13. Source-drain diode forward characteristics

Figure 14. Normalized BV_{DSS} vs. temperature



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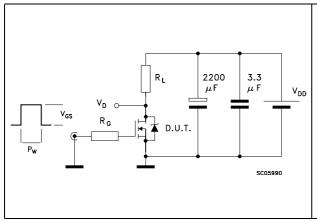


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3 Test circuit

Figure 15. Switching times test circuit for resistive load



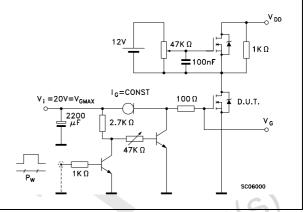
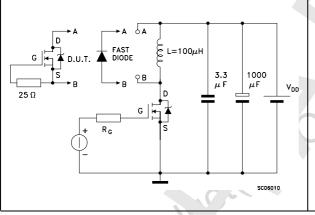
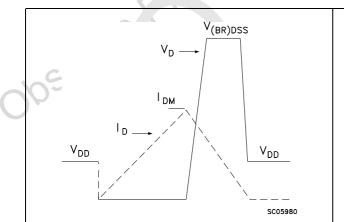


Figure 16. Gate charge test circuit

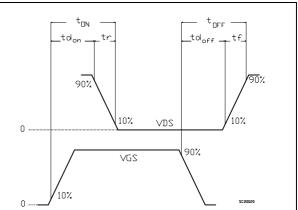
Figure 17. Test circuit for inductive load switching and diode recovery times







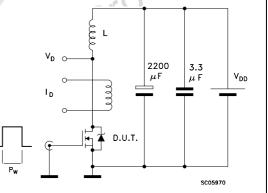




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Figure 18. Unclamped inductive load test

circuit



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4 Package mechanical data

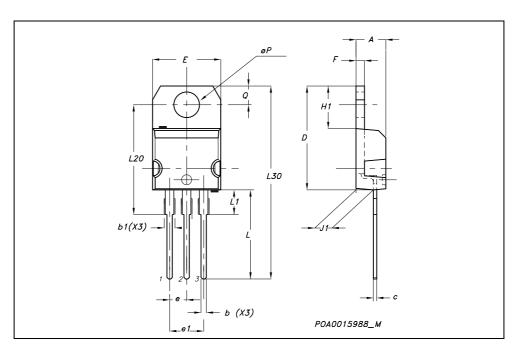
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com*

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DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øР	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



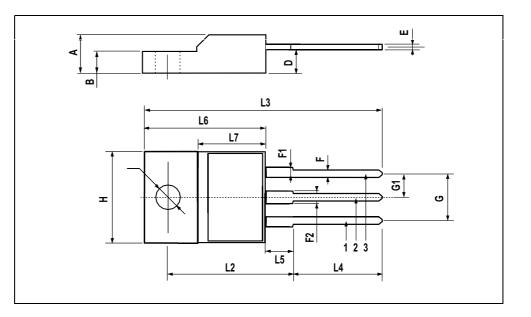




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TO-220FP MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



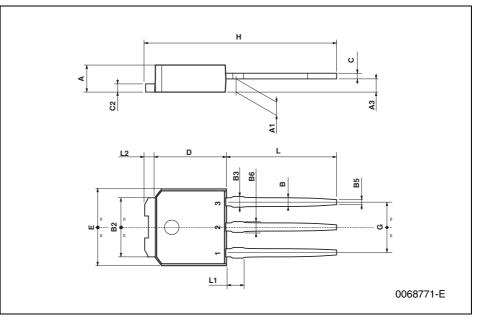
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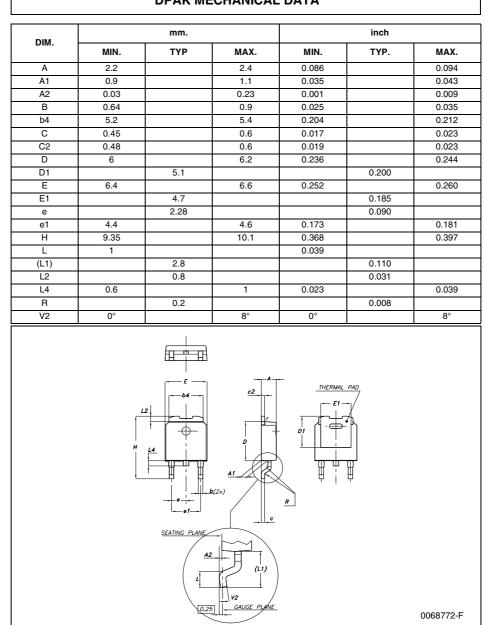
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
B3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047







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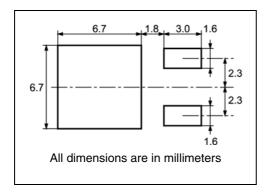


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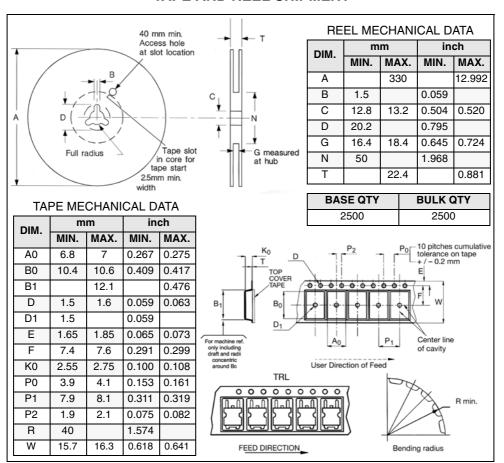


5 Packaging mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



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6 Revision history

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Table 8.	Revision	history
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Date	Revision	Changes
10-Apr-2007	1	First release

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